

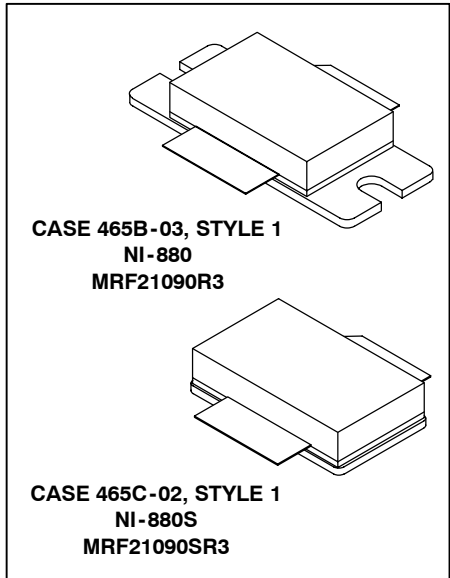
The RF Sub-Micron MOSFET Line
RF Power Field Effect Transistors
N-Channel Enhancement-Mode Lateral MOSFETs

MRF21090R3
MRF21090SR3

Designed for W-CDMA base station applications with frequencies from 2110 to 2170 MHz. Suitable for FM, TDMA, CDMA and multicarrier amplifier applications.

2170 MHz, 90 W, 28 V
LATERAL N-CHANNEL
RF POWER MOSFETs

- Typical W-CDMA Performance for 2140 MHz, 28 Volts
 4.096 MHz BW @ 5 MHz offset, 1 PERCH 15 DTCH:
 Output Power — 11.5 Watts
 Efficiency — 16%
 Gain — 12.2 dB
 ACPR — -45 dBc
- Internally Matched, Controlled Q, for Ease of Use
- High Gain, High Efficiency and High Linearity
- Integrated ESD Protection
- Designed for Maximum Gain and Insertion Phase Flatness
- Capable of Handling 10:1 VSWR, @ 28 Vdc, 2110 MHz, 90 Watts CW Output Power
- Excellent Thermal Stability
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- In Tape and Reel. R3 Suffix = 250 Units per 56 mm, 13 inch Reel.



MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	65	Vdc
Gate-Source Voltage	V_{GS}	+15, -0.5	Vdc
Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	P_D	270 1.54	Watts $\text{W}/^\circ\text{C}$
Storage Temperature Range	T_{stg}	- 65 to +150	$^\circ\text{C}$
Operating Junction Temperature	T_J	200	$^\circ\text{C}$

THERMAL CHARACTERISTICS

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	0.65	$^\circ\text{C}/\text{W}$

NOTE - CAUTION - MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.

Freescale Semiconductor, Inc.

ESD PROTECTION CHARACTERISTICS

Test Conditions		Class
Human Body Model	MRF21090R3 MRF21090SR3	2 (Minimum) 1 (Minimum)
Machine Model	MRF21090R3 MRF21090SR3	M3 (Minimum) M4 (Minimum)

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
----------------	--------	-----	-----	-----	------

OFF CHARACTERISTICS

Drain-Source Breakdown Voltage (V _{GS} = 0 Vdc, I _D = 100 μAdc)	V _{(BR)DSS}	65	—	—	Vdc
Gate-Source Leakage Current (V _{GS} = 5 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	—	—	1	μAdc
Zero Gate Voltage Drain Leakage Current (V _{DS} = 28 Vdc, V _{GS} = 0 Vdc)	I _{DSS}	—	—	10	μAdc

ON CHARACTERISTICS

Forward Transconductance (V _{DS} = 10 Vdc, I _D = 3 Adc)	g _{fs}	—	7.2	—	S
Gate Threshold Voltage (V _{DS} = 10 V, I _D = 300 μA)	V _{GS(th)}	2	3	4	Vdc
Gate Quiescent Voltage (V _{DS} = 28 V, I _D = 750 mA)	V _{GS(Q)}	3	3.8	5	Vdc
Drain-Source On-Voltage (V _{GS} = 10 V, I _D = 1 A)	V _{DS(on)}	—	0.1	0.6	Vdc

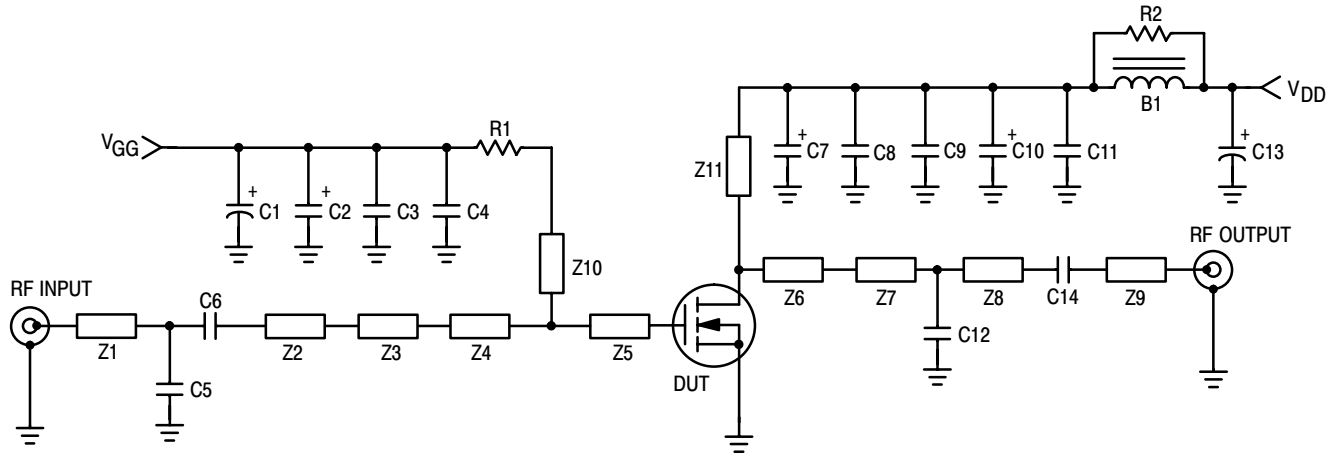
DYNAMIC CHARACTERISTICS

Reverse Transfer Capacitance (1) (V _{DS} = 28 Vdc, V _{GS} = 0, f = 1 MHz)	C _{rss}	—	4.2	—	pF
--	------------------	---	-----	---	----

FUNCTIONAL TESTS (In Motorola Test Fixture)

Common-Source Amplifier Power Gain (V _{DD} = 28 Vdc, P _{out} = 90 W PEP, I _{DQ} = 750 mA, f ₁ = 2110.0 MHz, f ₂ = 2110.1 MHz and f ₁ = 2170.0 MHz, f ₂ = 2170.1 MHz)	G _{ps}	10	11.7	—	dB
Drain Efficiency (V _{DD} = 28 Vdc, P _{out} = 90 W PEP, I _{DQ} = 750 mA, f ₁ = 2110.0 MHz, f ₂ = 2110.1 MHz and f ₁ = 2170.0 MHz, f ₂ = 2170.1 MHz)	η	30	33	—	%
Intermodulation Distortion (V _{DD} = 28 Vdc, P _{out} = 90 W PEP, I _{DQ} = 750 mA, f ₁ = 2110.0 MHz, f ₂ = 2110.1 MHz and f ₁ = 2170.0 MHz, f ₂ = 2170.1 MHz)	IMD	—	-30	-27.5	dBc
Input Return Loss (V _{DD} = 28 Vdc, P _{out} = 90 W PEP, I _{DQ} = 750 mA, f ₁ = 2110.0 MHz, f ₂ = 2110.1 MHz and f ₁ = 2170.0 MHz, f ₂ = 2170.1 MHz)	IRL	—	-12	-9.0	dB
Common-Source Amplifier Power Gain (V _{DD} = 28 Vdc, P _{out} = 75 W CW, I _{DQ} = 750 mA, f = 2170 MHz)	G _{ps}	—	11.7	—	dB
Drain Efficiency (V _{DD} = 28 Vdc, P _{out} = 75 W CW, I _{DQ} = 750 mA, f = 2170 MHz)	η	—	41	—	%
Output Mismatch Stress (V _{DD} = 28 Vdc, P _{out} = 90 W CW, I _{DQ} = 750 mA, f = 2110 MHz, VSWR = 10:1, All Phase Angles at Frequency of Tests)	Ψ	No Degradation In Output Power Before and After Test			

(1) Part is internally matched both on input and output.



B1	Ferrite Bead, Fair Rite #2743019447	Z7	10.23 x 2.09 mm Microstrip
C1, C13	470 μ F, 50 V Electrolytic Capacitors	Z8	6.03 x 2.09 mm Microstrip
C2, C10	22 μ F, 35 V Tantalum Surface Mount Chip Capacitors, Kemet	Z9	23.98 x 2.09 mm Microstrip
C3, C9	20 nF Chip Capacitors, ATC #100B203MCA500X	Z10	29.82 x 1.15 mm Microstrip
C4, C8	5.1 pF Chip Capacitors, ATC #100B5R1CCA500X	Z11	17.08 x 1.15 mm Microstrip
C5, C12	0.4 - 2.5 pF Variable Capacitors, Johanson Gigatrim	WS1, WS2	Beryllium Copper Wear Blocks 5 mils Thick
C6	10 pF Chip Capacitor, ATC #100B100JCA500X		Brass Banana Jack and Nut
C7	1 μ F, 35 V Tantalum Surface Mount Chip Capacitor, Kemet		Red Banana Jack and Nut
C11	1 nF Chip Capacitor, ATC #100B102JCA500X		Green Banana Jack and Nut
C14	8.2 pF Chip Capacitor, ATC #100B8R2CCA500X		Type N Jack Connectors, 3052-1648-10, Omni Specra
R1	13 Ω , 1/4 W Chip Resistor, Garret Instrument #RM73B2B130JT,		4-40 Head Screws 0.125" Long
R2	12 Ω , 1/4 W Chip Resistor, Garret Instrument #RM73B2B120JT		4-40 Head Screws 0.188" Long
Z1	30.7 x 2.09 mm Microstrip		4-40 Head Screws 0.312" Long
Z2	5.99 x 2.09 mm Microstrip		4-40 Head Screws 0.438" Long
Z3	7.55 x 9.89 mm Microstrip		
Z4	3.77 x 15.71 mm Microstrip		
Z5	6.89 x 26.17 mm Microstrip		
Z6	14.93 x 32.05 mm Microstrip		
		Endplates Brass	Endplates for Copper Bedstead
		Bedstead	Copper Bedstead/Heatsink
		Insert	Copper Bedstead Insert
		Raw PCB	0.030" Glass Teflon [®] , 2 oz Copper Clad
			3" x 5" Arion
		RF Circuit	3" x 5" Copper Clad PCB Teflon [®] , MRF21090, CMR

Figure 1. MRF21090R3(SR3) Test Circuit Schematic

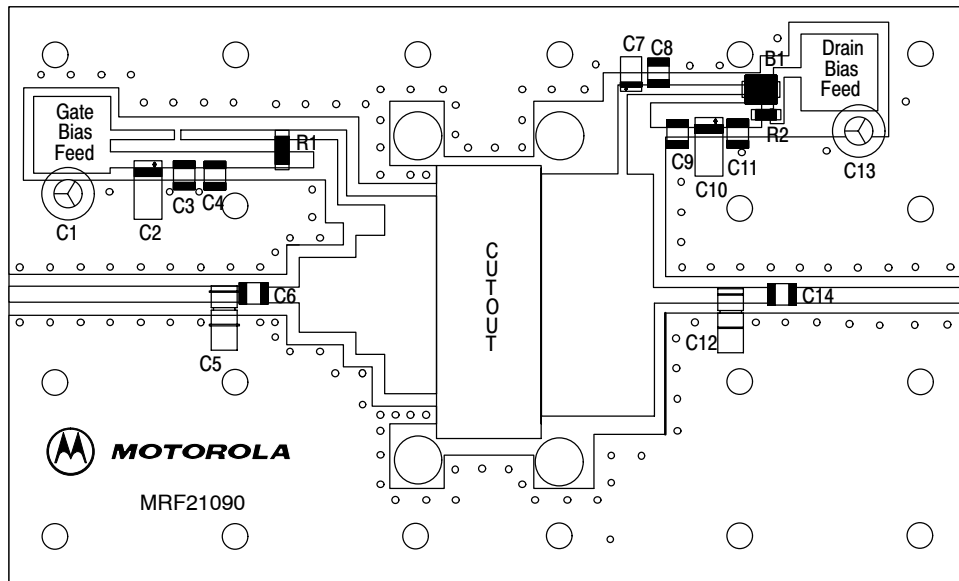


Figure 2. MRF21090R3(SR3) Test Circuit Component Layout

Freescale Semiconductor, Inc.

TYPICAL PERFORMANCE (IN MOTOROLA TEST FIXTURE)

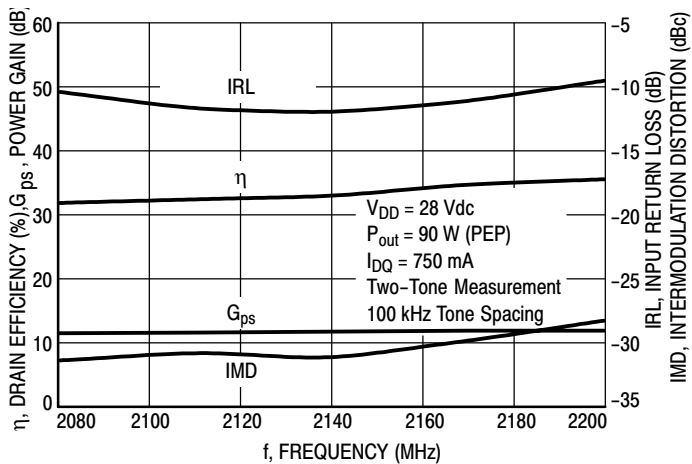


Figure 3. Class AB Broadband Circuit Performance

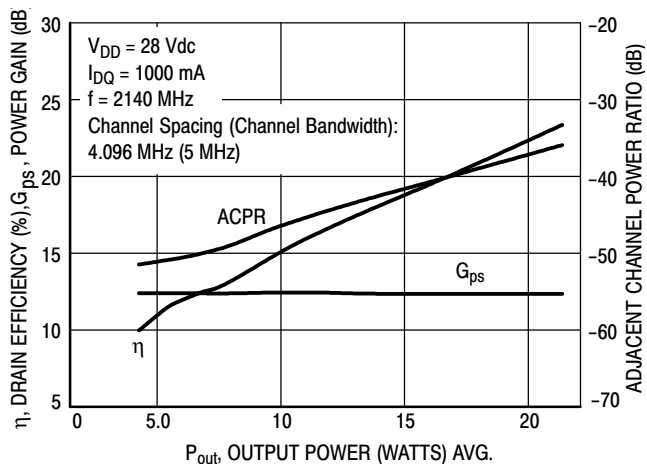


Figure 4. CDMA ACPR, Power Gain and Drain Efficiency versus Output Power

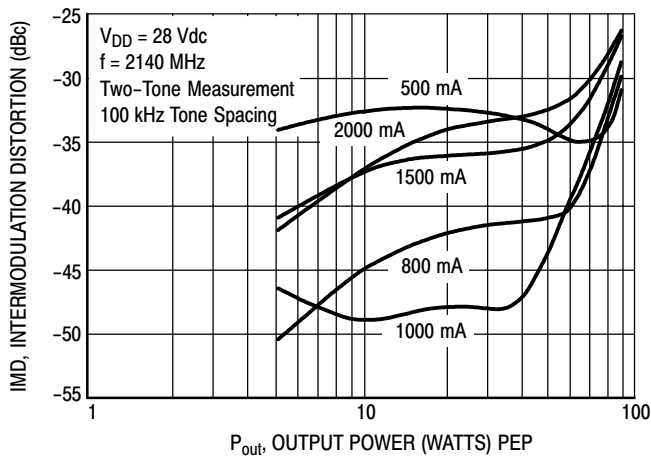


Figure 5. Intermodulation Distortion versus Output Power

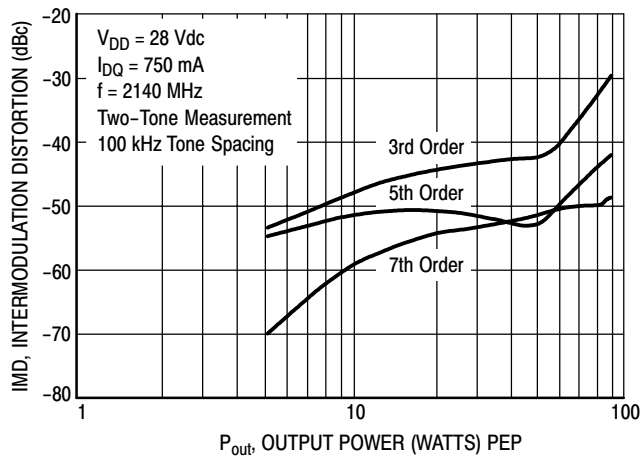


Figure 6. Intermodulation Distortion Products versus Output Power

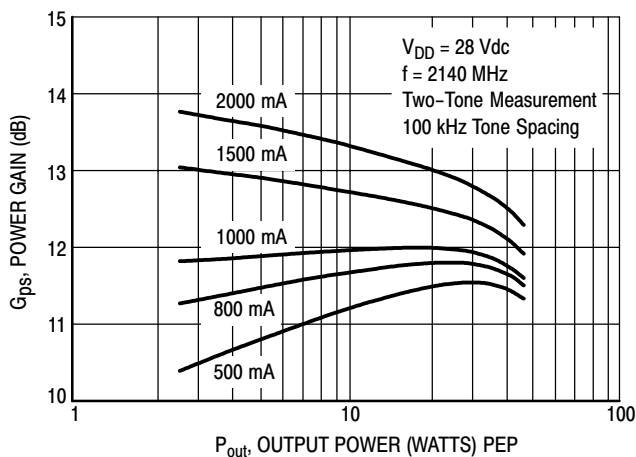


Figure 7. Power Gain versus Output Power

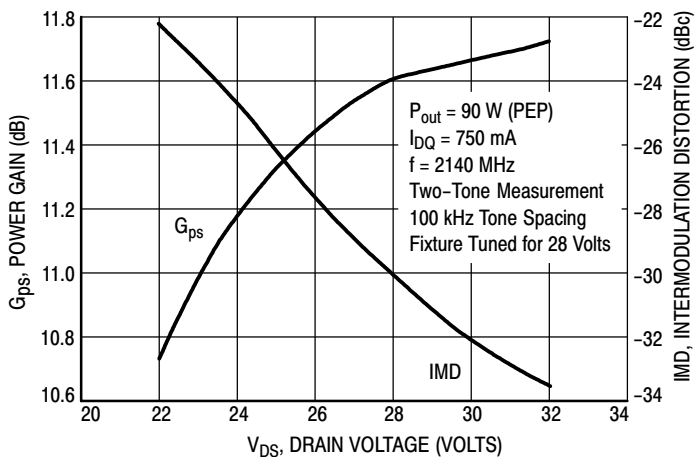
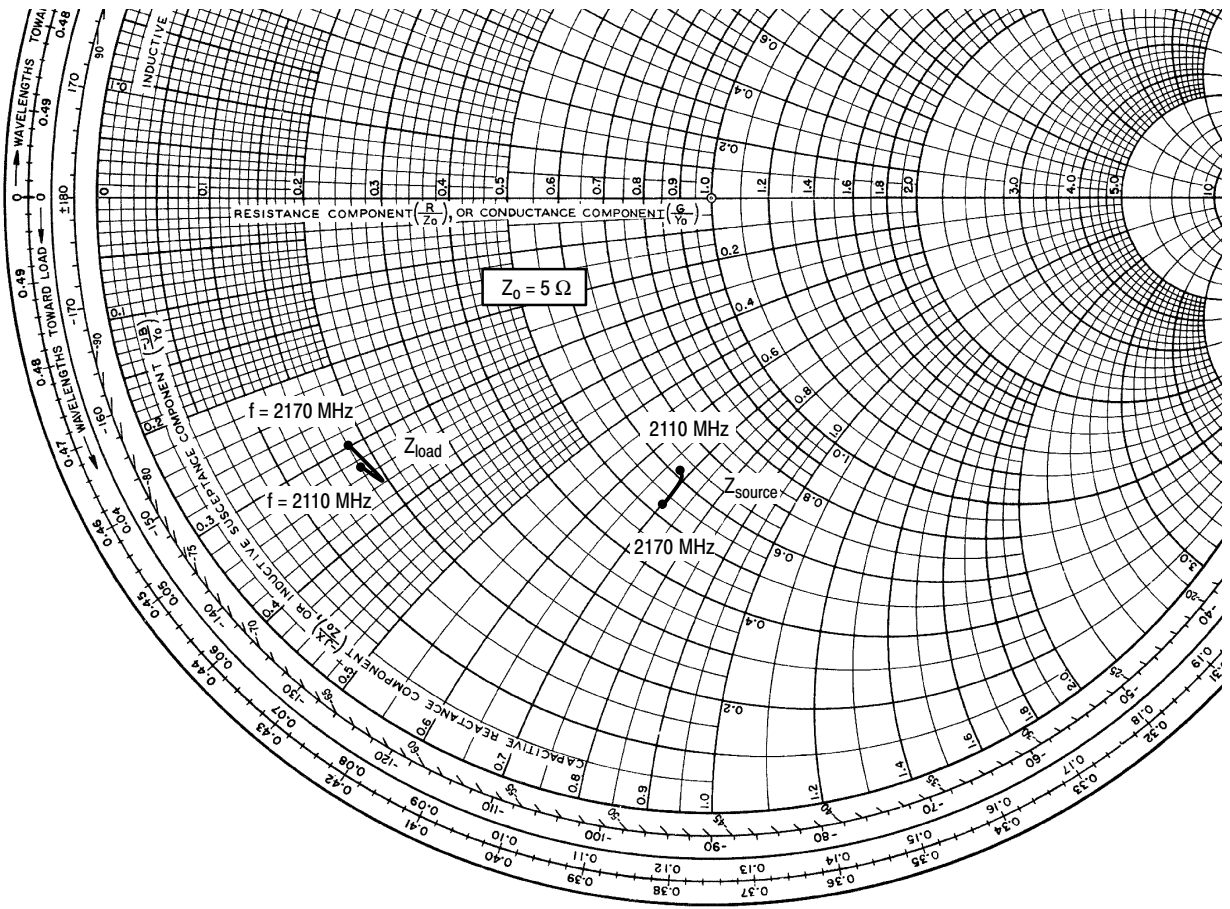


Figure 8. Power Gain and Intermodulation Distortion versus Supply Voltage



$V_{DD} = 28\text{ V}$, $I_{DQ} = 750\text{ mA}$, $P_{out} = 90\text{ W (PEP)}$

f MHz	Z_{source} Ω	Z_{load} Ω
2110	3.03 - j3.40	0.92 - j1.67
2140	3.02 - j3.46	0.97 - j1.80
2170	2.60 - j3.50	0.90 - j1.52

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

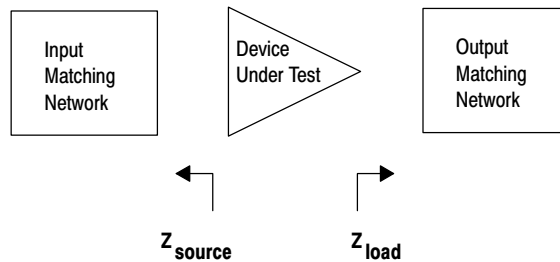
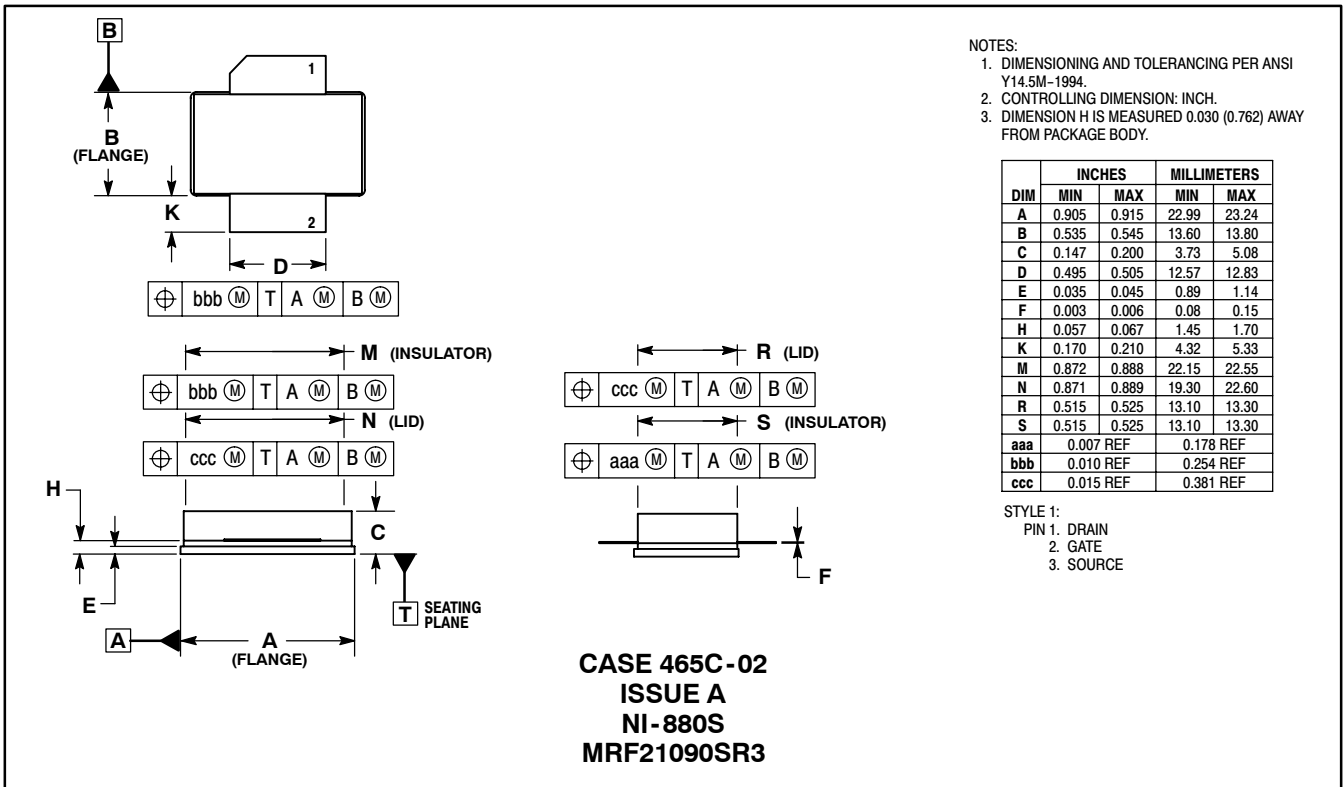
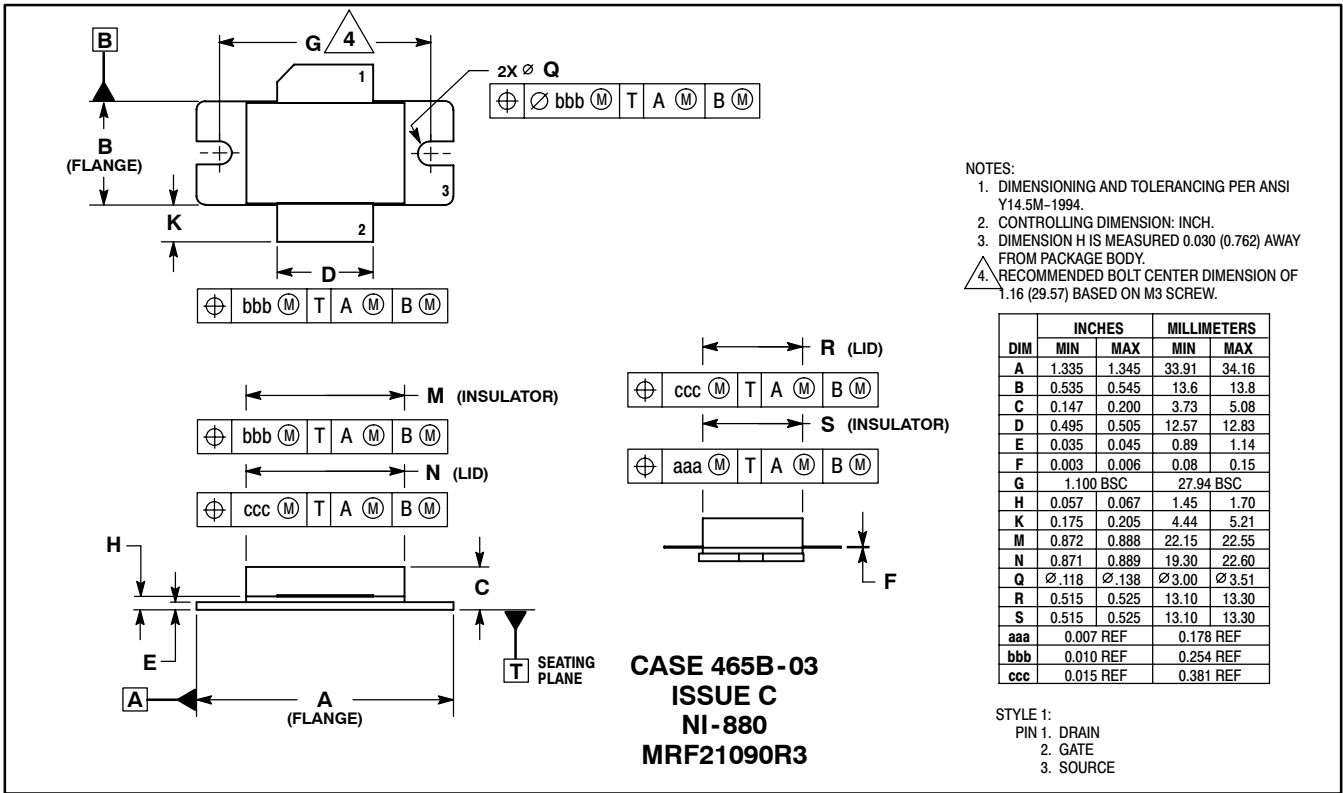


Figure 9. Series Equivalent Source and Load Impedance

NOTES

Freescale Semiconductor, Inc.

PACKAGE DIMENSIONS



Information in this document is provided solely to enable system and software implementers to use Motorola products. There are no express or implied copyright licenses granted hereunder to design or fabricate any integrated circuits or integrated circuits based on the information in this document.

Motorola reserves the right to make changes without further notice to any products herein. Motorola makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Motorola assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters that may be provided in Motorola data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals", must be validated for each customer application by customer's technical experts. Motorola does not convey any license under its patent rights nor the rights of others. Motorola products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the Motorola product could create a situation where personal injury or death may occur. Should Buyer purchase or use Motorola products for any such unintended or unauthorized application, Buyer shall indemnify and hold Motorola and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that Motorola was negligent regarding the design or manufacture of the part.

MOTOROLA and the Stylized M Logo are registered in the US Patent and Trademark Office. All other product or service names are the property of their respective owners. Motorola, Inc. is an Equal Opportunity/Affirmative Action Employer.

© Motorola Inc. 2004

HOW TO REACH US:

USA/EUROPE/LOCATIONS NOT LISTED:
Motorola Literature Distribution
P.O. Box 5405, Denver, Colorado 80217
1-800-521-6274 or 480-768-2130

JAPAN: Motorola Japan Ltd.; SPS, Technical Information Center,
3-20-1, Minami-Azabu, Minato-ku, Tokyo 106-8573, Japan
81-3-3440-3569

ASIA/PACIFIC: Motorola Semiconductors H.K. Ltd.; Silicon Harbour Centre,
2 Dai King Street, Tai Po Industrial Estate, Tai Po, N.T., Hong Kong
852-26668334

HOME PAGE: <http://motorola.com/semiconductors>



◇ **For More Information On This Product,
Go to: www.freescale.com**

MRF21090/D